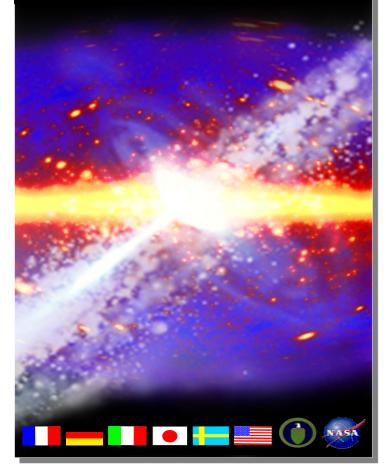


Gamma-ray Large Area Space Telescope



Latest and greatest from offline analysis with real TKR data

L. Baldini, M. Kuss, N. Omodei, C. Sgro



A different view on xmlGeoDbs: the trays...



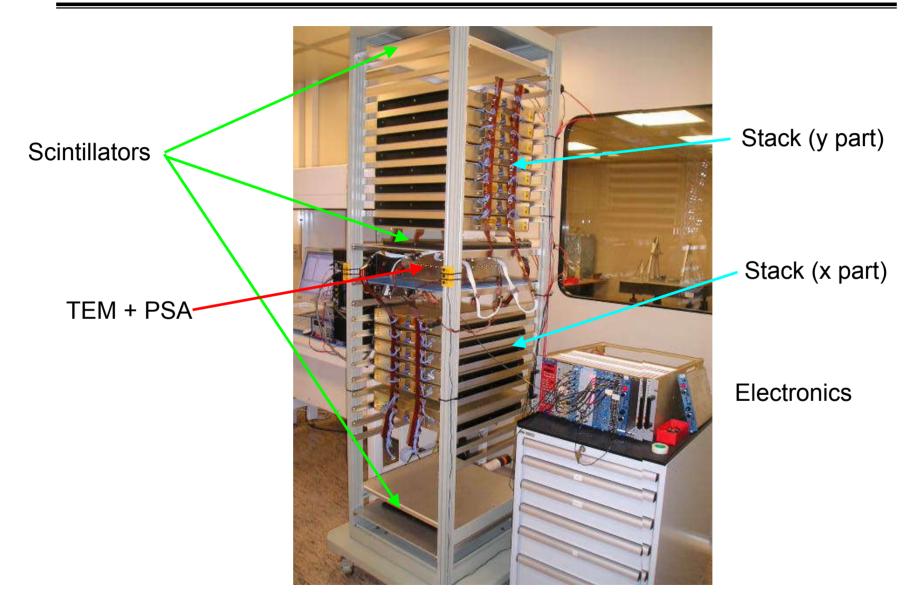
The tray shipping containers provide:
✓ Protection from contamination and accidental mishandling.
✓ Full testing capabilities (electrical connection possible without opening the box by means of connector savers.).



The trays are being removed from the boxes right before the final stacking into the tower assembly jig.



...and the stack!





Data taking trigger configurations

Three in a row:

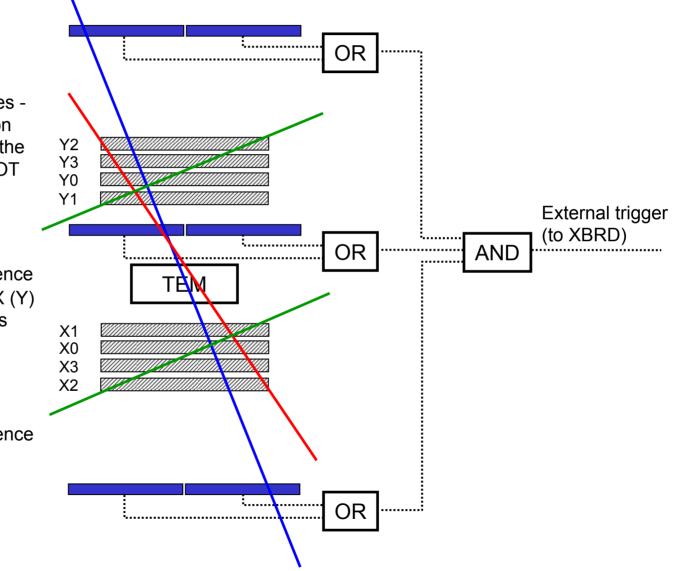
trigger on three consecutive X-Y planes coincidence of 6 silicon layers - even thought the layers involved are NOT close to each other.

Stack X (Y) only:

trigger on the coincidence of three consecutive X (Y) layers - all Y (X) layers forced to be ON.

External trigger:

trigger on the coincidence of the three external scintillator planes.





Standard approach: ⇒ *RootTreeAnalysis*. It reads mc, digi, and recon files, predefines histograms and writes them into another root file.

You need to hard-code:

- what to histogram
- . dimensions and binning (no way to zoom on details later)
- cuts

Our approach: ⇒ LeaningTower. runTreeMaker fills all interesting quantities into one single tree. All the relevant information can be retrieved by means of some standard tools.

All the dimensions, binning and cuts can be easily modified interactively!



runTreeMaker.cxx, TreeMaker.cxx merges digi and recon files into one single tree

loaded by compile.C:

Layer.cxx Tracker.cxx

Event.cxx

EventDisplay.cxx

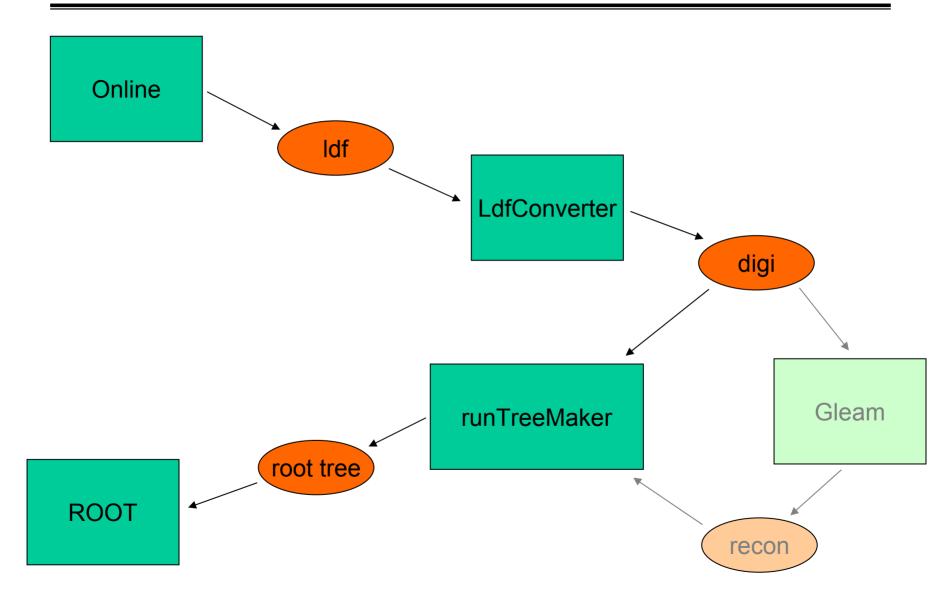
PlotMacros.C

contains geometry description of stack/tower defines Event class Event display (also residuals and efficiency estimate, for now!)

collection of macros to ease plotting of interesting quantities.



Analysis Flow

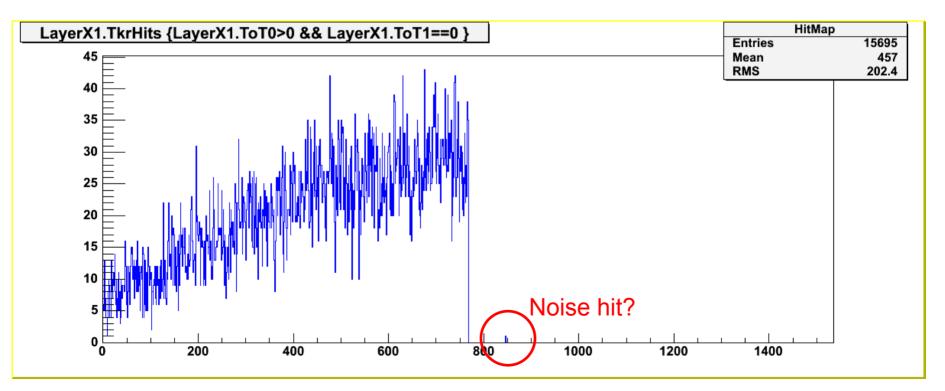


Instrument Analysis Workshop, SLAC, September 27 2004



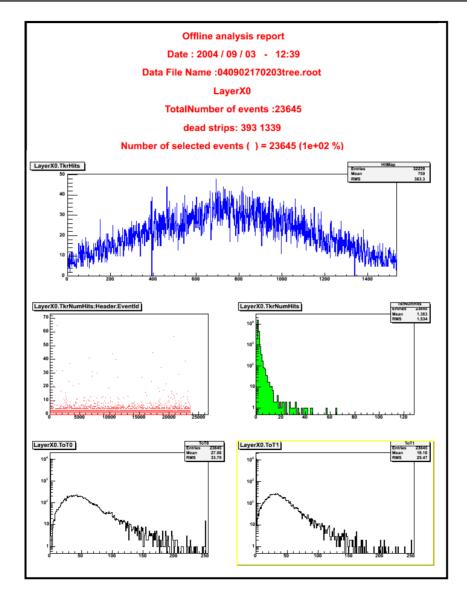
Plota avariable applying the union applying the uni

- > RadeayeMapraggerX1.Torniet@s&&01ByedXtheordet0macros.
- > Addlageiźex1RogtFile.root") // Load the data file.
- > RddtHyeMápX1LayerX20TEkHhtss8009\$; the focus on layer X1.
- > PlotHitMap(); // Plot the hitmap.





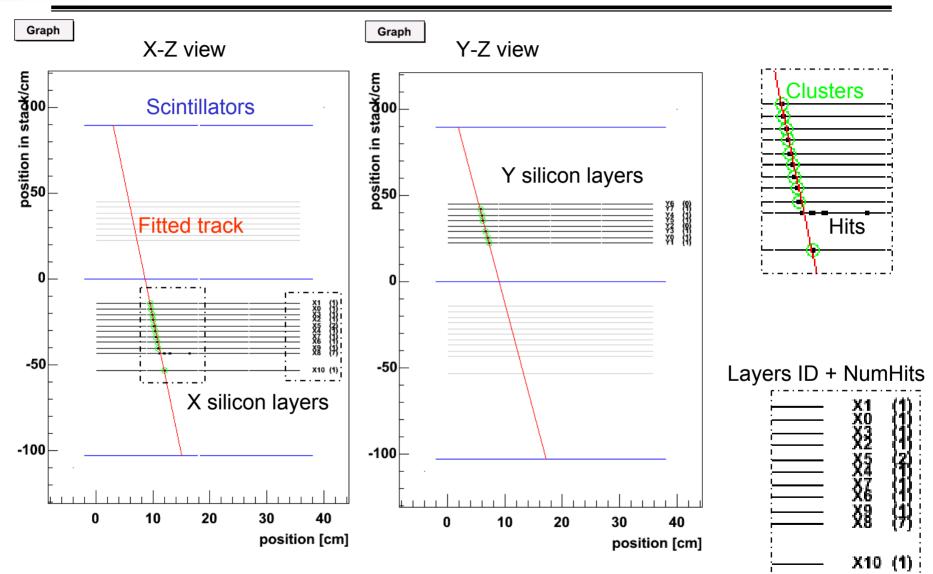
An example of Offline Report



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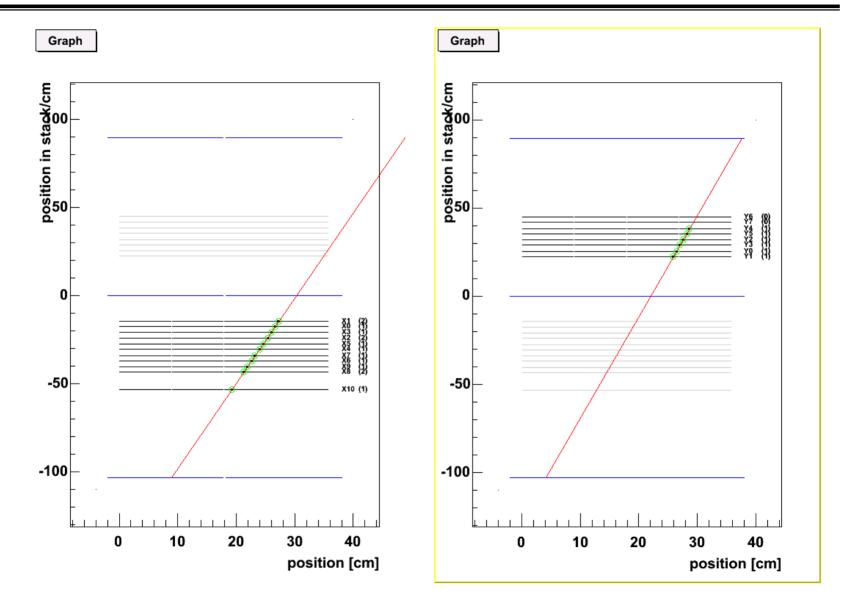
The event display



L. Baldini

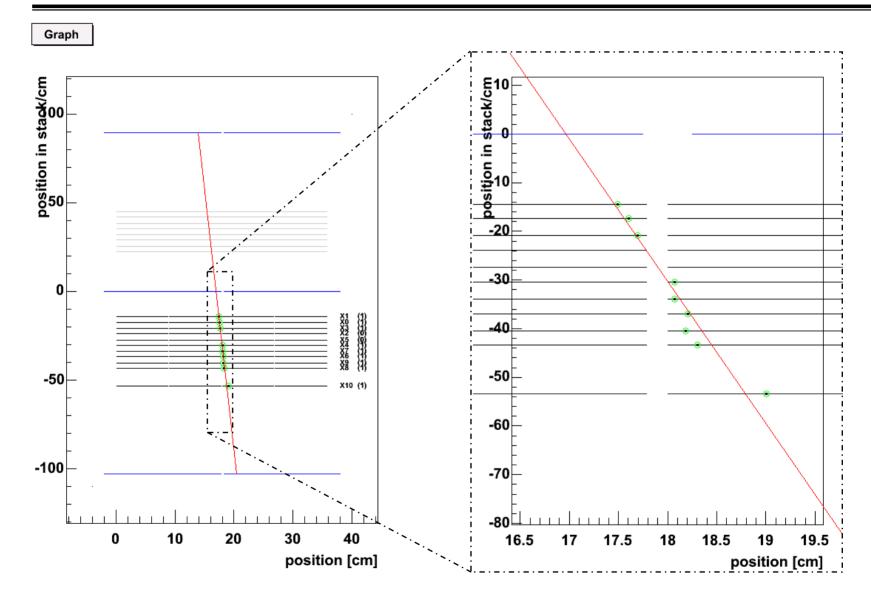


Some sample events



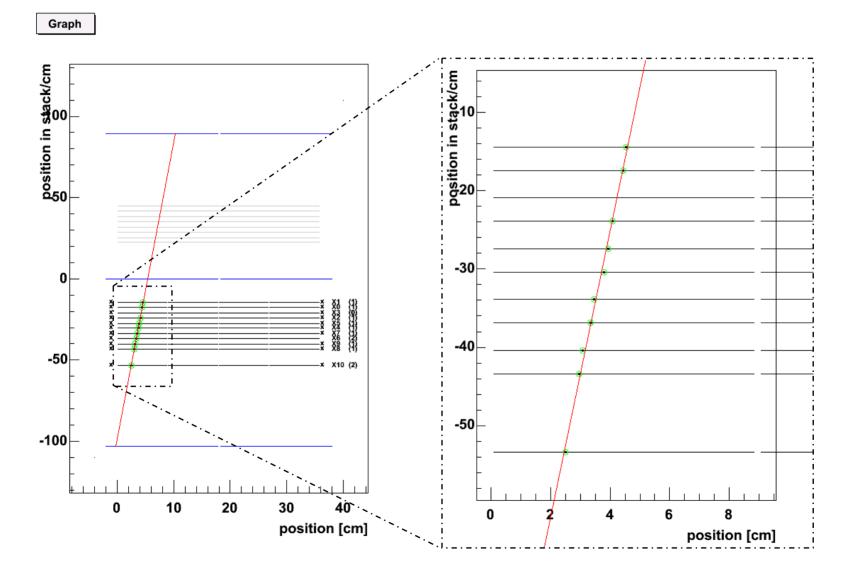


"Missing" hits: the cracks





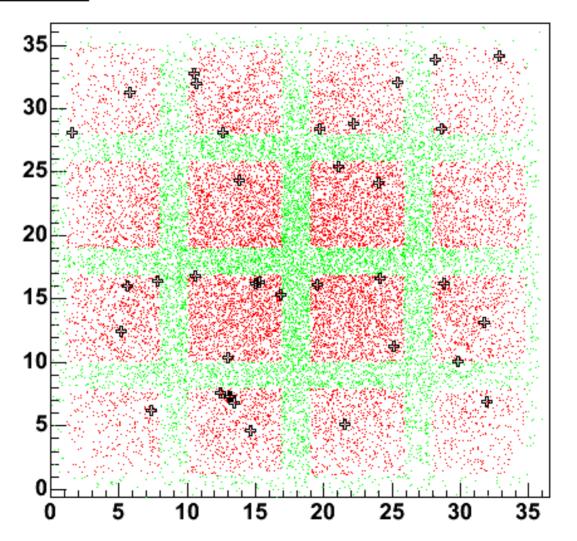
Hit inefficiencies (1)



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Graph



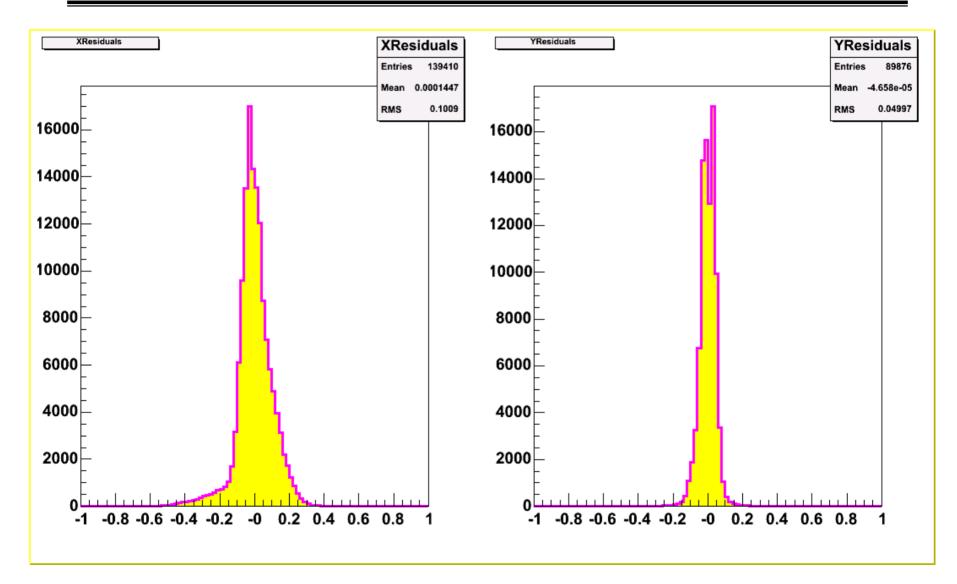


Detection efficiency measurement

Layer ID	Measured efficiency (23399 evts)	Number of bad channels	
Y6	13.2 %	1399	
Y7	92.9 %	253	
Y4	94.9 %	230	
Y5	98.9 %	25	
Y2	95.8 %	143	
Y3	97.5 %	77	
Y0	99.8 %	0	
Y1	95.2 %	165	
X1	99.7 %	0	
X0	99.7 %	2	
X3	99.7 %	0	
X2	99.6 %	3	
X5	99.6 %	3	
X4	99.6 %	0	
Х7	99.6 %	1	
X6	99.6 %	0	
Х9	99.5 %	7	
X8	99.4 %	19	
X10	99.4 %	0	

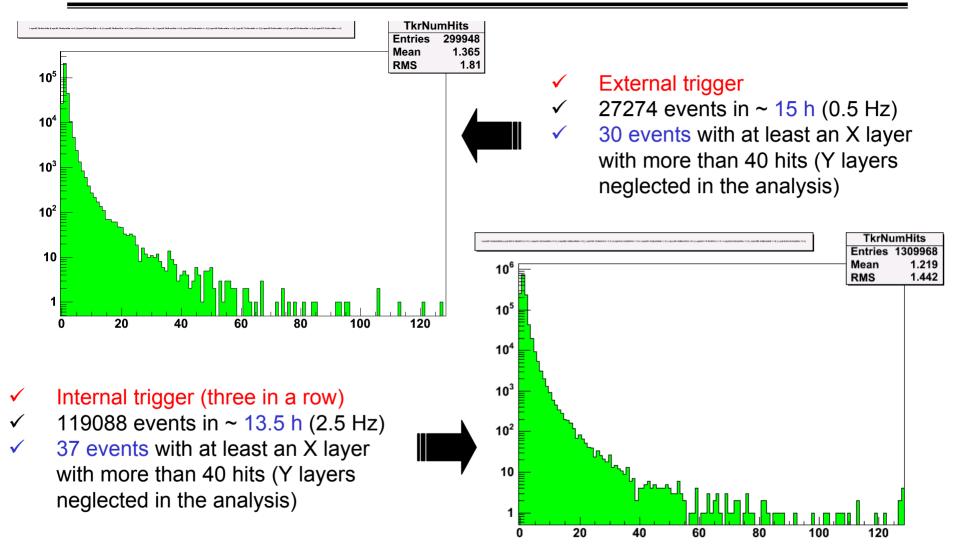


Residuals distributions





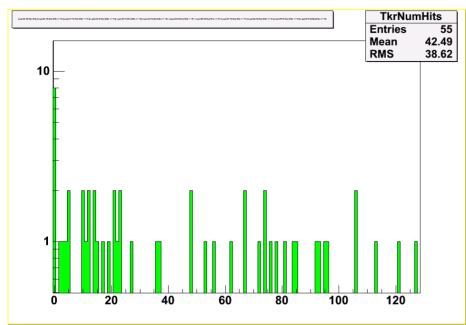
Events with large hit multiplicity (1)



The fraction of events with very high hit multiplicity doesn't scale with the trigger rate.



Events with large hit multiplicity (2)



Hit multiplicity distribution on different layers uncorrelated between each other \rightarrow mean value of the histogram slightly dependent on the cut.

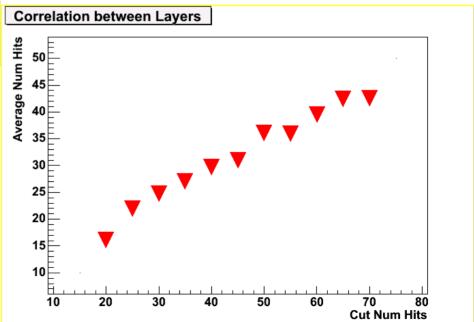
Hit multiplicity distribution on different layers correlated \rightarrow mean value of the histogram strongly dependent on the cut.

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Investigate the hit correlation between different layers:

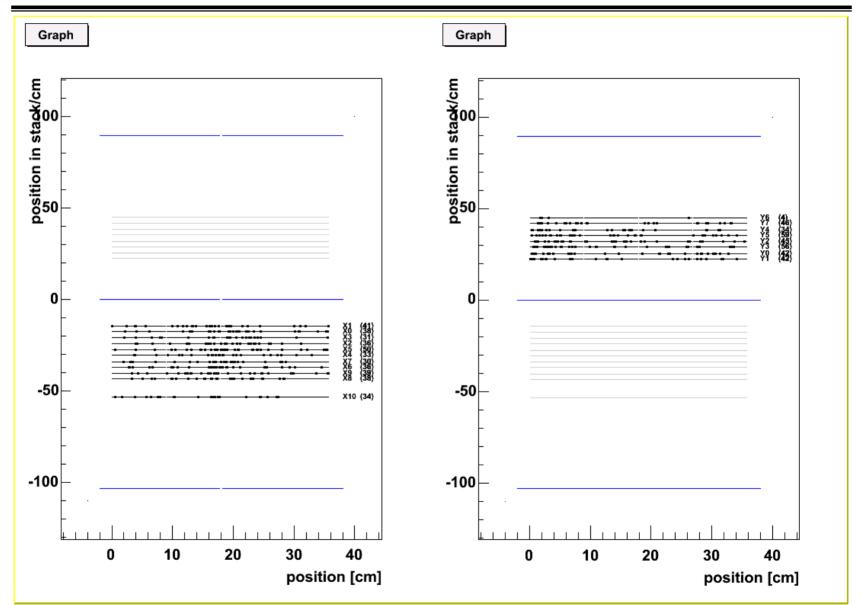
✓ Select those events having more than a given number of hits (20, 25 ... 70) on at least on layer.

 \checkmark Fill a histogram with the hit multiplicity values from all the layers.



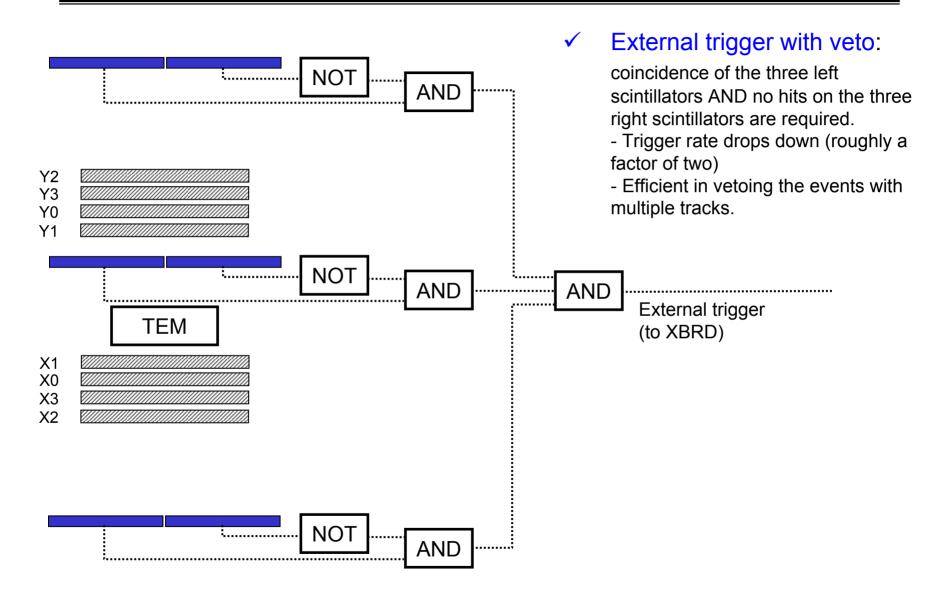


Events with large hit multiplicity (3)



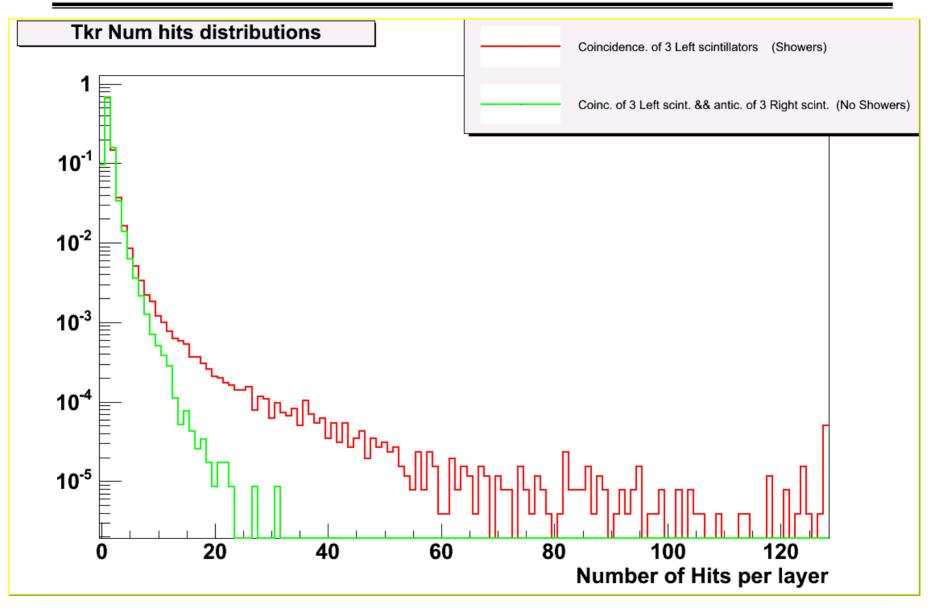


Showers veto trigger configuration





Hit multiplicity distribution after shower veto





glastserver@Pisa

	stop	lastserver.pi.infn.it/TkrElectricalTests New&Cool	.html	V Search Print	t - M
		GLAST Silicon Tra	acker electrical tests		
he following pages contain det	ailed informatior	about the tests performed on the T	racker hardware at all the levels of integrati	on.	
		Here is the GUII General display Single layer display	1 X		
		-Event display - circular buffer and refresh settings [15000] 코 Circular buffer see10 코 Interval count	- Data - circular buffer and refresh settings 1000 정 Circular buffer ice 년0 중 Internal count		
		Event display -X2 projection Event display (X2 view)	Event display - YZ projection Event display (YZ view)		
		Totel number of hits Totel number of hits	Three in now combinations Number of progen requests		
		0 10 20 30 40 Total number of hits			
MCMs incoming tests		Augus 27, 2004, Event contected with	a stack of 10 trays (no channels masked).		
Single trays tests Stacked trays tests Towers tests Screenshots					
View <u>all</u> EGSE test session				en de la companya de	
		网络伊朗福德西			

http://glastserver.pi.infn.it/TkrElectricalTests.html

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Conclusions



...chasing for tower 0 data...